

**Search Notes**

Application/Control No.

10/664,649

Examiner

Devin Hanan

Applicant(s)/Patent under  
Reexamination

HEEG ET AL.

Art Unit

3745

**SEARCHED**

Class	Subclass	Date	Examiner
416	97R		
	115		
	96A		
	96R		
	92	4/15/2005	DH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Consulted Chris Verdier on classes 415 and 416	4/7/2005	DH